## Notice of References Cited Application/Control No. O9/883,659 Examiner Feben M Haile Applicant(s)/Patent Under Reexamination ZDAN, MICHAEL A. Page 1 of 1

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,542,466	04-2003	Pashtan et al.	370/235
	В	US-2003/0012144	01-2003	Nichols, Kathleen M.	370/252
	С	US-2003/0112756	06-2003	Le Gouriellec et al.	370/230
	٥	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	ı	US-			·
	J	US-			
	к	US-	•		
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
Z					
0					
Р					
a					
R					
S	•			·	
Т					

## NON-PATENT BOCUMENTS

	MONT ATENT DEGINERTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	٧			
	w			
	x			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. O9/883,659 Applicant(s)/Patent Under Reexamination ZDAN, MICHAEL A. Examiner Feben M. Haile Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0068965 A1	03-2005	Lin et al.	370/395.21
	В	US-6,614,790 B1	09-2003	Veres et al.	370/395.2
	С	US-2005/0078602 A1	04-2005	Mancour et al.	370/235
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			·
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	7					
	0					
	Р					
	ď					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.